



# CS1N65 B3

## General Description:

CS1N65 B3, the silicon N-channel Enhanced VDMOSFETs, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-251, which accords with the RoHS standard.

## Features:

- I **Fast Switching**
- I **Low ON Resistance**( $R_{ds(on)} \leq 9.5\Omega$ )
- I **Low Gate Charge** (Typical Data:5.3nC)
- I **Low Reverse transfer capacitances**(Typical:2pF)
- I **100% Single Pulse avalanche energy Test**

## Applications:

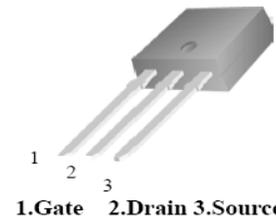
Power switch circuit of adaptor and charger.

**Absolute** ( $T_c = 25^\circ\text{C}$  unless otherwise specified):

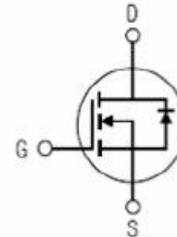
| Symbol         | Parameter  | Rating              | Units               |
|----------------|--|---------------------|---------------------|
| $V_{DSS}$      | Drain-to-Source Voltage                            | 650                 | V                   |
| $I_D$          | Continuous Drain Current                           | 1.5                 | A                   |
|                | Continuous Drain Current $T_C = 100^\circ\text{C}$ | 0.85                | A                   |
| $I_{DM}^{a1}$  | Pulsed Drain Current                               | 6.0                 | A                   |
| $V_{GS}$       | Gate-to-Source Voltage                             | $\pm 30$            | V                   |
| $E_{AS}^{a2}$  | Single Pulse Avalanche Energy                      | 25                  | mJ                  |
| $E_{AR}^{a1}$  | Avalanche Energy ,Repetitive                       | 5                   | mJ                  |
| $I_{AR}^{a1}$  | Avalanche Current                                  | 1                   | A                   |
| $dv/dt^{a3}$   | Peak Diode Recovery dv/dt                          | 5.0                 | V/ns                |
| $P_D$          | Power Dissipation                                  | 32                  | W                   |
|                | Derating Factor above $25^\circ\text{C}$           | 0.256               | W/ $^\circ\text{C}$ |
| $T_J, T_{stg}$ | Operating Junction and Storage Temperature Range   | 150, $-55$ to $150$ | $^\circ\text{C}$    |
| $T_L$          | Maximum Temperature for Soldering                  | 300                 | $^\circ\text{C}$    |

|                              |     |          |
|------------------------------|-----|----------|
| $V_{DSS}$                    | 650 | V        |
| $I_D$                        | 1.5 | A        |
| $P_D (T_C=25^\circ\text{C})$ | 32  | W        |
| $R_{DS(ON)Typ}$              | 8.5 | $\Omega$ |

### TO-251



### Inner Equivalent Principium Chart



## Electrical Characteristics ( $T_c = 25^\circ\text{C}$ unless otherwise specified):

| OFF Characteristics          |                                   |  |        |      |      |               |
|------------------------------|-----------------------------------|--|--------|------|------|---------------|
| Symbol                       | Parameter                         | Test Conditions                                      | Rating |      |      | Units         |
|                              |                                   |  | Min.   | Typ. | Max. |               |
| $V_{DSS}$                    | Drain to Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$                            | 650    | --   | --   | V             |
| $\Delta BV_{DSS}/\Delta T_J$ | Bvdss Temperature Coefficient     | $I_D=250\mu A, \text{Reference } 25^\circ C$         | --     | 0.55 | --   | V/ $^\circ C$ |
| $I_{DSS}$                    | Drain to Source Leakage Current   | $V_{DS} = 650V, V_{GS} = 0V,$<br>$T_a = 25^\circ C$  | --     | --   | 1    | $\mu A$       |
|                              |                                   | $V_{DS} = 520V, V_{GS} = 0V,$<br>$T_a = 125^\circ C$ | --     | --   | 100  |               |
| $I_{GSS(F)}$                 | Gate to Source Forward Leakage    | $V_{GS} = +30V$                                      | --     | --   | 100  | nA            |
| $I_{GSS(R)}$                 | Gate to Source Reverse Leakage    | $V_{GS} = -30V$                                      | --     | --   | -100 | nA            |

| ON Characteristics                               |                               |                                   |        |      |      |          |
|--|-------------------------------|-----------------------------------|--------|------|------|----------|
| Symbol   | Parameter                     | Test Conditions                   | Rating |      |      | Units    |
|  |                               |                                   | Min.   | Typ. | Max. |          |
| $R_{DS(ON)}$                                     | Drain-to-Source On-Resistance | $V_{GS}=10V, I_D=0.75A$           | --     | 8.5  | 9.5  | $\Omega$ |
| $V_{GS(TH)}$                                     | Gate Threshold Voltage        | $V_{DS} = V_{GS}, I_D = 250\mu A$ | 2.0    |      | 4.0  | V        |
| Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$ |                               |                                   |        |      |      |          |

| Dynamic Characteristics |                              |   |        |      |      |       |
|-------------------------|------------------------------|---|--------|------|------|-------|
| Symbol                  | Parameter                    | Test Conditions                             | Rating |      |      | Units |
|                         |                              |   | Min.   | Typ. | Max. |       |
| $g_{fs}$                | Forward Trans conductance    | $V_{DS}=30V, I_D = 0.75A$                   | --     | 1.0  | --   | S     |
| $C_{iss}$               | Input Capacitance            | $V_{GS} = 0V, V_{DS} = 25V$<br>$f = 1.0MHz$ | --     | 139  | --   | pF    |
| $C_{oss}$               | Output Capacitance           |   | --     | 17   | --   |       |
| $C_{rss}$               | Reverse Transfer Capacitance |   | --     | 2    | --   |       |

| Resistive Switching Characteristics |                                 |  |        |      |      |       |
|-------------------------------------|---------------------------------|--|--------|------|------|-------|
| Symbol                              | Parameter                       | Test Conditions  | Rating |      |      | Units |
|                                     |                                 |  | Min.   | Typ. | Max. |       |
| $t_{d(ON)}$                         | Turn-on Delay Time              | $I_D = 1.5A, V_{DD} = 325V$<br>$V_{GS} = 10V, R_G = 4.7\Omega$ | --     | 6    | --   | ns    |
| $t_r$                               | Rise Time                       |  | --     | 4.5  | --   |       |
| $t_{d(OFF)}$                        | Turn-Off Delay Time             |  | --     | 27   | --   |       |
| $t_f$                               | Fall Time                       |  | --     | 16   | --   |       |
| $Q_g$                               | Total Gate Charge               | $I_D = 1.5A, V_{DD} = 325V$<br>$V_{GS} = 10V$                  | --     | 5.3  |      | nC    |
| $Q_{gs}$                            | Gate to Source Charge           |  | --     | 0.7  |      |       |
| $Q_{gd}$                            | Gate to Drain ("Miller") Charge |  | --     | 2.6  |      |       |

| Source-Drain Diode Characteristics               |  |                              |        |      |      |       |
|--|--|------------------------------|--------|------|------|-------|
| Symbol   | Parameter                              | Test Conditions              | Rating |      |      | Units |
|  |  |                              | Min.   | Typ. | Max. |       |
| $I_S$  | Continuous Source Current (Body Diode) |                              | --     | --   | 1.5  | A     |
| $I_{SM}$   | Maximum Pulsed Current (Body Diode)    |                              | --     | --   | 6.0  | A     |
| $V_{SD}$   | Diode Forward Voltage                  | $I_S=1.5A, V_{GS}=0V$        | --     | --   | 1.5  | V     |
| $t_{rr}$   | Reverse Recovery Time                  | $I_S=1.5A, T_j = 25^\circ C$ | --     | 65   |      | ns    |
| $Q_{rr}$   | Reverse Recovery Charge                | $dI_F/dt=100A/us, V_{GS}=0V$ | --     | 101  |      | nC    |
| Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$ |  |                              |        |      |      |       |

| Symbol          | Parameter           | Typ. | Units        |
|-----------------|---------------------|------|--------------|
| $R_{\theta JC}$ | Junction-to-Case    | 3.91 | $^\circ C/W$ |
| $R_{\theta JA}$ | Junction-to-Ambient | 62.5 | $^\circ C/W$ |

<sup>a1</sup>: Repetitive rating; pulse width limited by maximum junction temperature

<sup>a2</sup>:  $L=10.0mH, I_D=2.2A, Start T_j=25^\circ C$

<sup>a3</sup>:  $I_{SD}=1.5A, di/dt \leq 100A/us, V_{DD} \leq BV_{DS}, Start T_j=25^\circ C$

## Characteristics Curve:

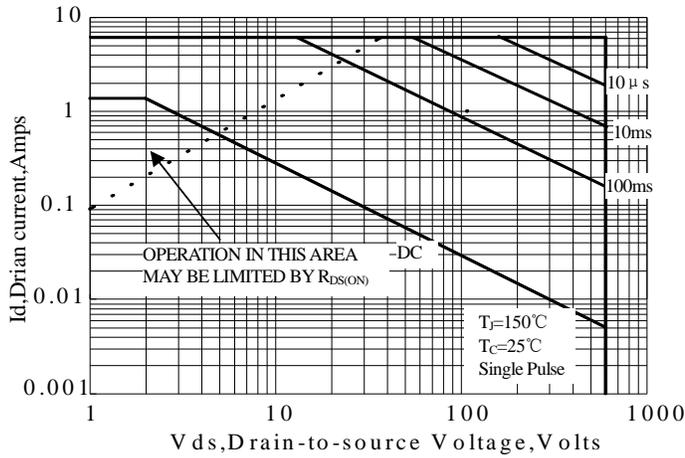


Figure 1 Maximum Forward Bias Safe Operating Area

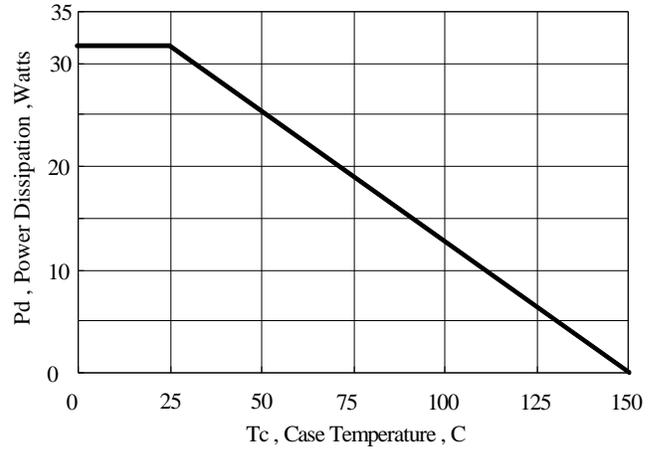


Figure 2 Maximum Power Dissipation vs Case Temperature

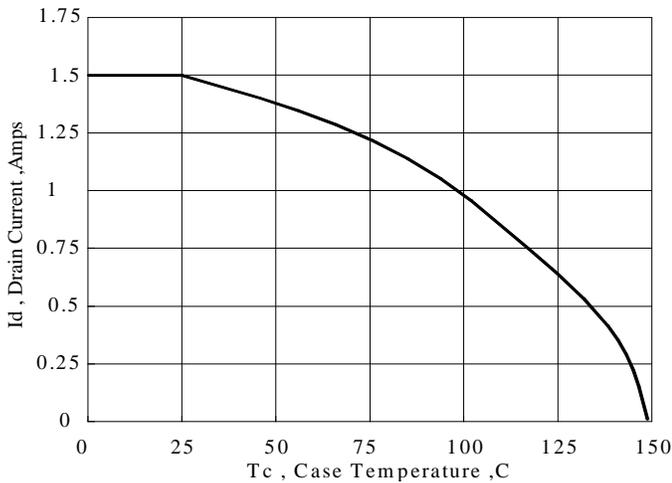


Figure 3 Maximum Continuous Drain Current vs Case Temperature

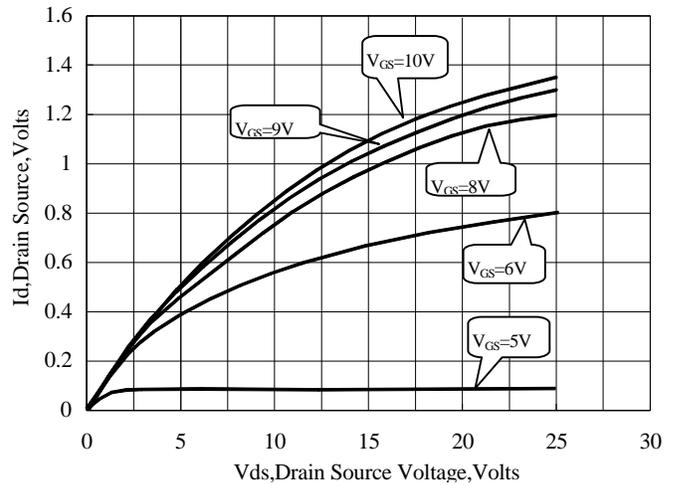


Figure 4 Typical Output Characteristics

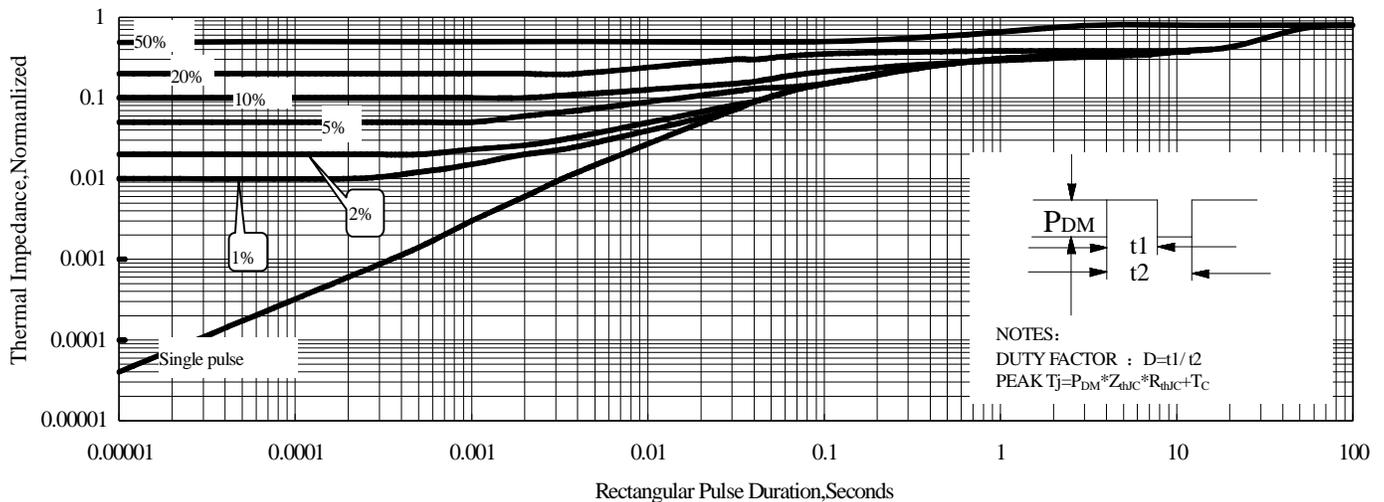


Figure 5 Maximum Effective Thermal Impedance, Junction to Case

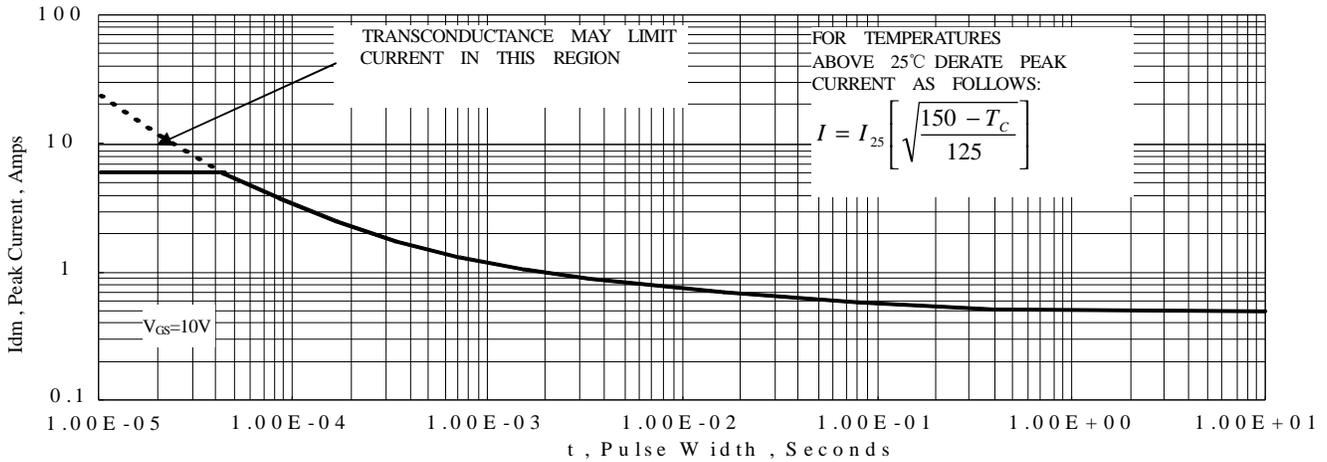


Figure 6 Maximum Peak Current Capability

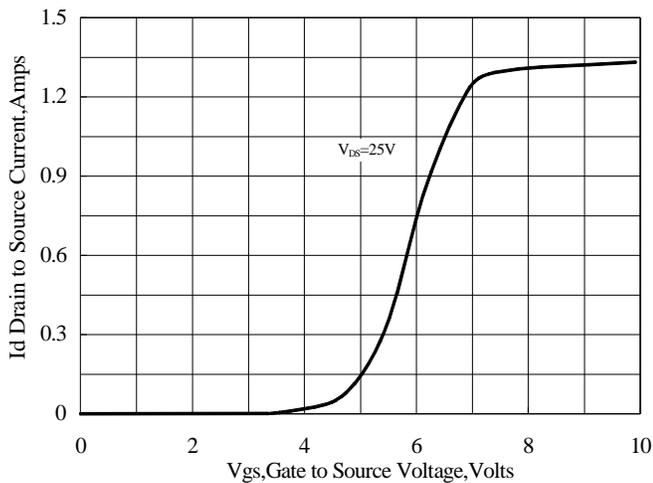


Figure 7 Typical Transfer Characteristics

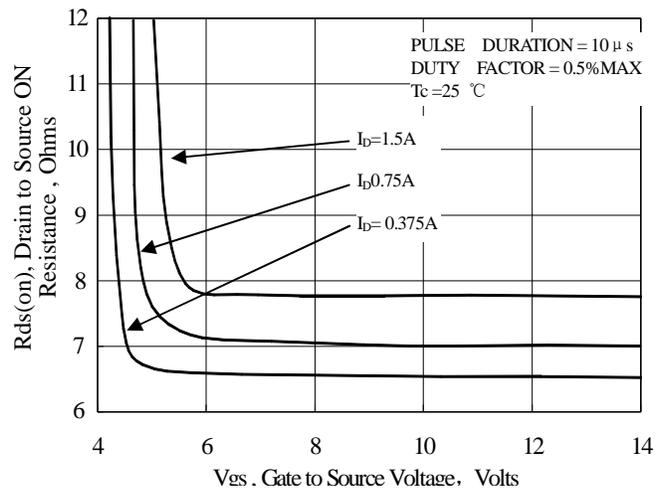


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

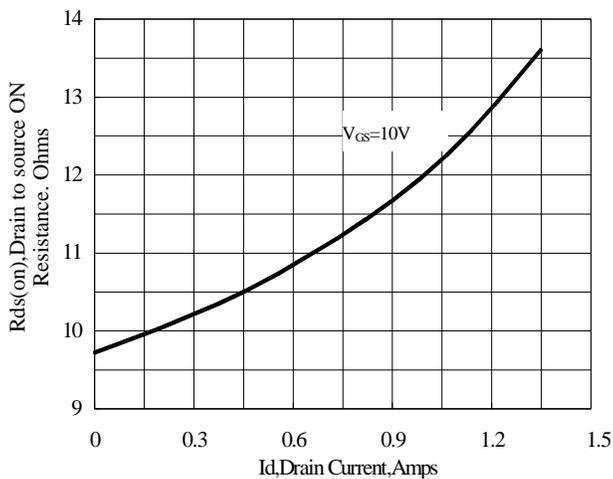


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

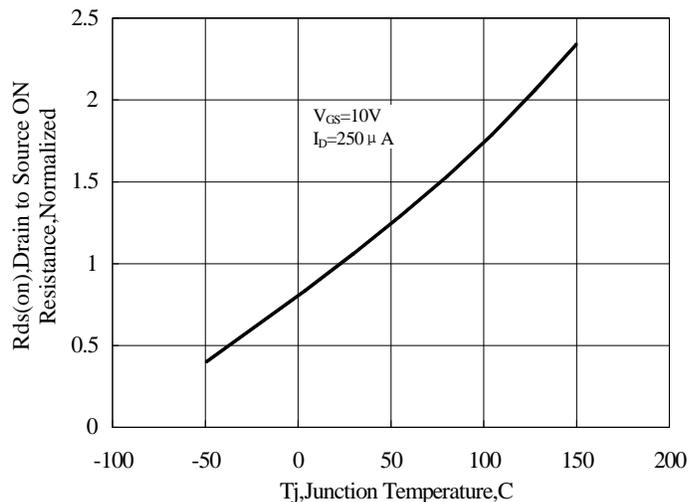


Figure 10 Typical Drain to Source on Resistance vs Junction Temperature

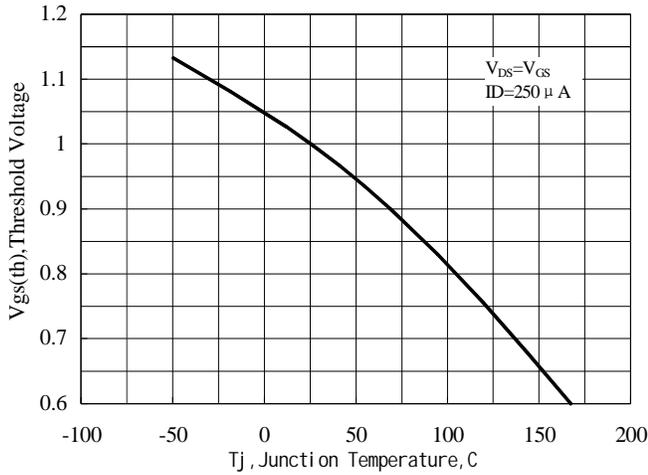


Figure 11 Typical Theshold Voltage vs Junction Temperature

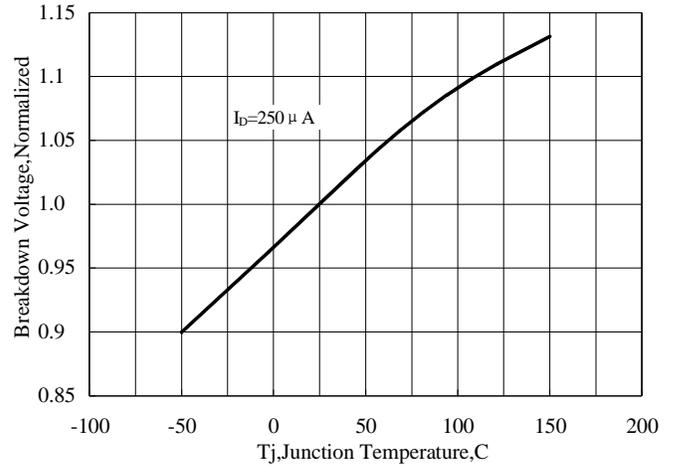


Figure 12 Typical Breakdown Voltage vs Junction Temperature

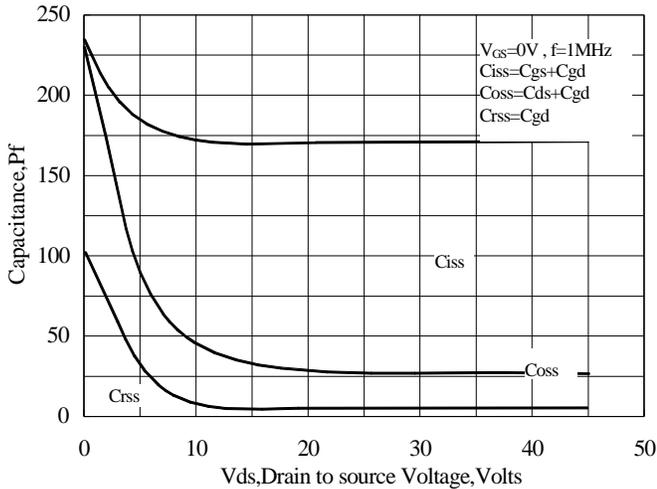


Figure 13 Typical Capacitance vs Drain to Source Voltage

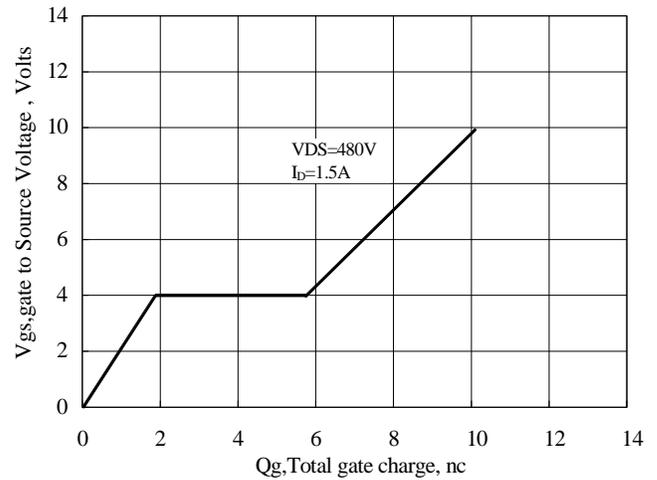


Figure 14 Typical Gate Charge vs Gate to Source Voltage

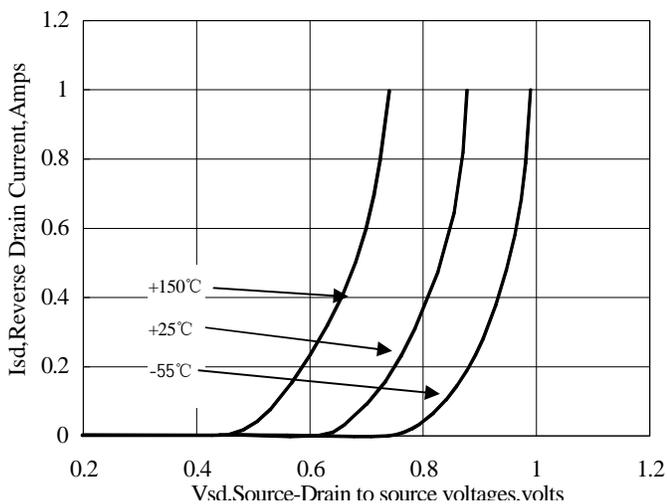


Figure 15 Typical Body Diode Transfer Characteristics

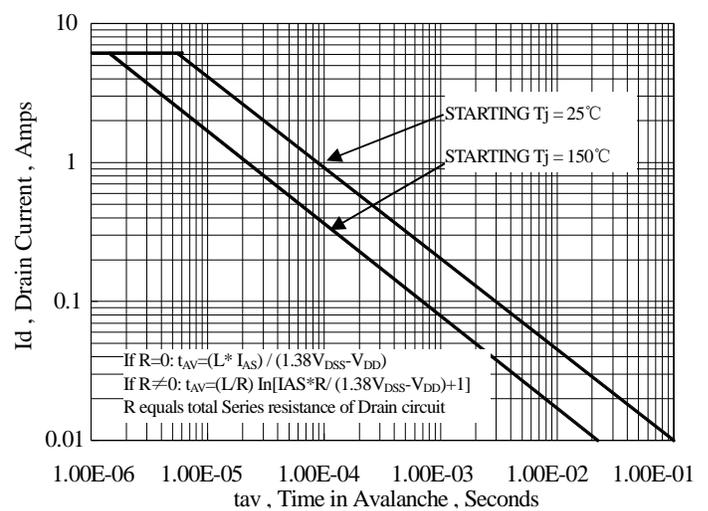


Figure 16 Unclamped Inductive Switching Capability

## Test Circuit and Waveform

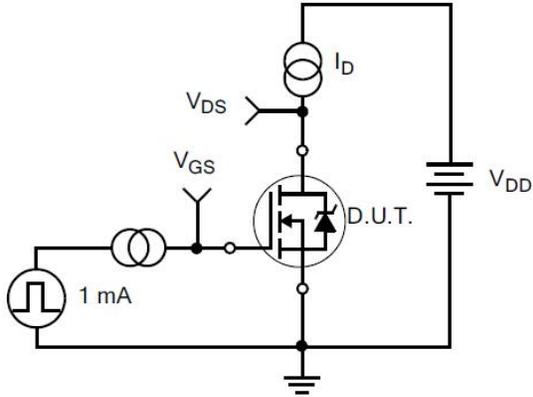


Figure 17. Gate Charge Test Circuit

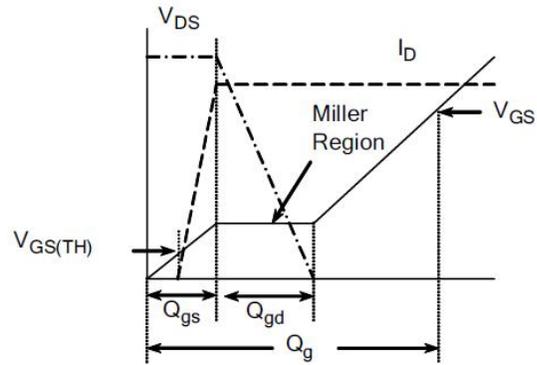


Figure 18. Gate Charge Waveform

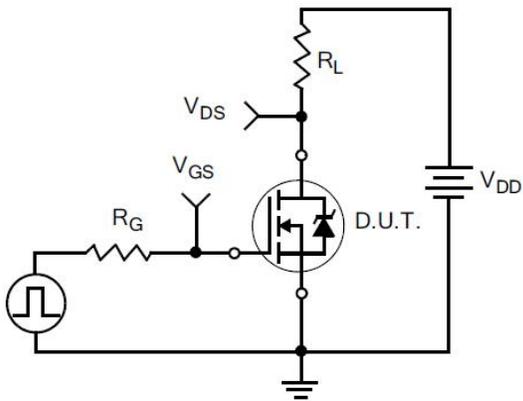


Figure 19. Resistive Switching Test Circuit

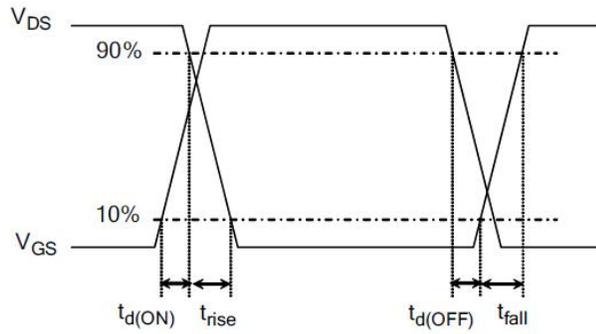


Figure 20. Resistive Switching Waveforms

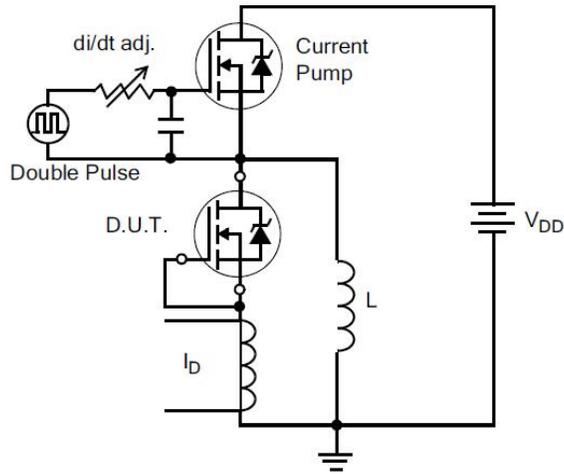


Figure 21. Diode Reverse Recovery Test Circuit

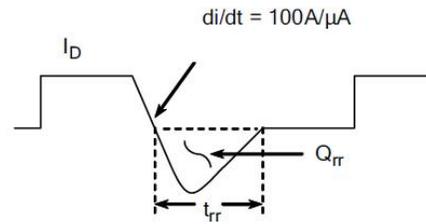


Figure 22. Diode Reverse Recovery Waveform

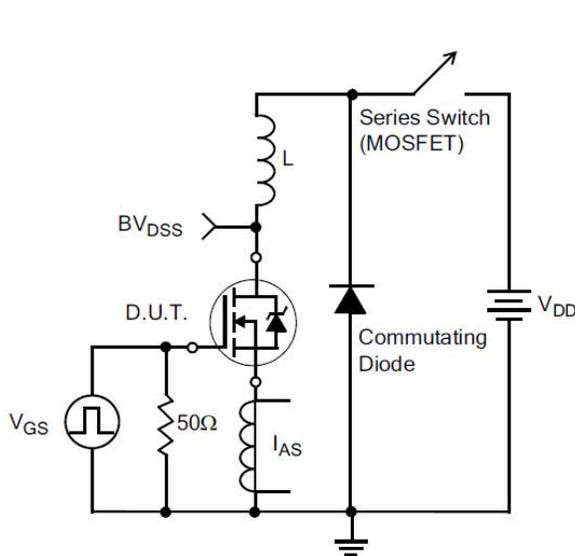


Figure 23. Unclamped Inductive Switching Test Circuit

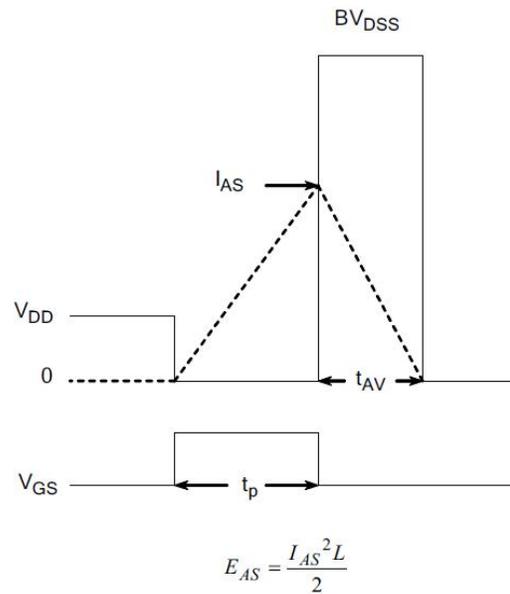
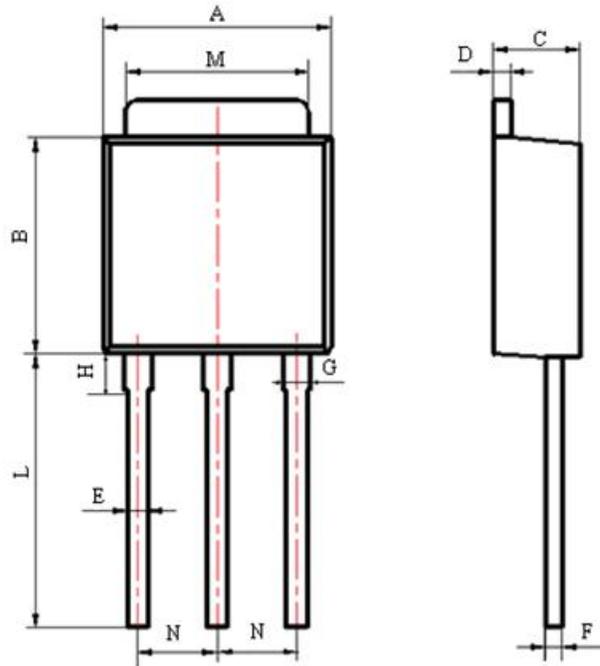


Figure 24. Unclamped Inductive Switching Waveforms

## Package Information:



| Items | Values(mm) |      |
|-------|------------|------|
|       | MIN        | MAX  |
| A     | 6.30       | 6.90 |
| B     | 5.70       | 6.30 |
| C     | 2.10       | 2.50 |
| D     | 0.30       | 0.60 |
| E     | 0.50       | 0.70 |
| F     | 0.30       | 0.60 |
| G     | 0.70       | 1.00 |
| H     | 1.60       | 2.40 |
| L     | 7.70       | 9.80 |
|       | 6.00       | 6.30 |
|       | 4.50       | 5.80 |
|       | 2.10       | 3.70 |
| M     | 5.10       | 5.50 |
| N     | 2.09       | 2.49 |

TO-251 Package

